


<b>Search Notes</b> 	<b>Application/Control No.</b> 10088400	<b>Applicant(s)/Patent Under Reexamination</b> HANTKE ET AL.
	<b>Examiner</b> Shengjun Wang	<b>Art Unit</b> 1617

SEARCHED			
Class	Subclass	Date	Examiner
424	484-488,500,501	11/08/2008	sw

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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